

Session KK

Microwave Measurements

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Chairman:

D. Wait

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The microwave measurements for the properties of materials, for characterization of microwave components, and for microwave systems are included in this session. In particular broadband measurements, time domain measurements, and on-wafer measurements are current challenges.

8:30 a.m.–10:00 a.m., Thursday, June 17, 1993
Room 215

